



## **AOT460**

## N-Channel Enhancement Mode Field Effect Transistor

## **General Description**

The AOT460/L uses advanced trench technology and design to provide excellent  $R_{\text{DS(ON)}}$  with low gate charge. This device is suitable for use in UPS, high current switching applications.

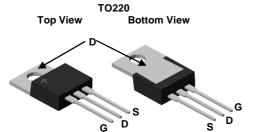
AOT460and AOT460L are electrically identical.

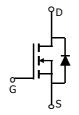
- -RoHS Compliant
- -Halogen Free

#### **Features**

$$\begin{split} V_{DS} & (V) = 60V \\ I_{D} = 85 \text{ A} & (V_{GS} = 10V) \\ R_{DS(ON)} < 7.5 \text{m}\Omega & (V_{GS} = 10V) \end{split}$$

100% UIS Tested!





Absolute Maximum Ratings T <sub>A</sub> =25℃ unless otherwise noted								
Parameter		Symbol	Maximum	Units				
Drain-Source Voltage		$V_{DS}$	60	V				
Gate-Source Voltage		$V_{GS}$	±20	V				
Continuous Drain	T <sub>C</sub> =25℃		85					
Current <sup>G</sup>	T <sub>C</sub> =100℃	$I_D$	66	Α				
Pulsed Drain Current <sup>C</sup>		I <sub>DM</sub>	340					
Avalanche Current <sup>C</sup>		I <sub>AR</sub>	80	А				
Repetitive avalanche energy L=0.1mH <sup>C</sup>		E <sub>AR</sub>	320	mJ				
	T <sub>C</sub> =25℃	P <sub>D</sub>	268	W				
Power Dissipation <sup>B</sup>	ssipation <sup>B</sup> T <sub>C</sub> =100℃		134	]				
Junction and Storage Temperature Range		$T_J, T_{STG}$	-55 to 175	C				

Thermal Characteristics									
Parameter	Symbol	Symbol Typ Max		Units					
Maximum Junction-to-Ambient A	Steady-State	$R_{\theta JA}$	45	60	℃/W				
Maximum Junction-to-Case <sup>B</sup>	Steady-State	$R_{ heta JC}$	0.45	0.56	℃/W				



#### Electrical Characteristics (T<sub>J</sub>=25℃ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
STATIC F	PARAMETERS					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	I <sub>D</sub> =250uA, V <sub>GS</sub> =0V	60			V
I <sub>DSS</sub>	Zava Cata Valtaga Brain Current	V <sub>DS</sub> =60V, V <sub>GS</sub> =0V			10	μΑ
	Zero Gate Voltage Drain Current	T <sub>J</sub> =55℃			50	
$I_{GSS}$	Gate-Body leakage current	$V_{DS}$ =0V, $V_{GS}$ =±20V			100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$ , $I_{D}=250\mu A$	2	2.95	4	V
I <sub>D(ON)</sub>	On state drain current	$V_{GS}$ =10V, $V_{DS}$ =5V	340			Α
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	$V_{GS}$ =10V, $I_D$ =30A		6.3	7.5	mΩ
		T <sub>J</sub> =125℃		10.5	13	
g <sub>FS</sub>	Transconductance	$V_{DS}$ =5V, $I_{D}$ =30A		90		S
$V_{SD}$	Diode Forward Voltage	I <sub>S</sub> =1A, V <sub>GS</sub> =0V		0.7	1	V
I <sub>S</sub>	Maximum Body-Diode Continuous Current <sup>G</sup>				85	Α
DYNAMIC	PARAMETERS					
C <sub>iss</sub>	Input Capacitance			3800	4560	pF
C <sub>oss</sub>	Output Capacitance	$V_{GS}$ =0V, $V_{DS}$ =30V, f=1MHz		430		pF
$C_{rss}$	Reverse Transfer Capacitance			190		pF
$R_g$	Gate resistance	$V_{GS}$ =0V, $V_{DS}$ =0V, f=1MHz		1.5	2.3	Ω
SWITCHI	NG PARAMETERS					
Q <sub>g</sub> (10V)	Total Gate Charge			68	88	nC
Q <sub>g</sub> (4.5V)	Total Gate Charge	V <sub>GS</sub> =10V, V <sub>DS</sub> =30V, I <sub>D</sub> =30A		33		nC
$Q_{gs}$	Gate Source Charge	VGS-10V, VDS-30V, ID-30A		15		nC
$Q_{gd}$	Gate Drain Charge			19		nC
t <sub>D(on)</sub>	Turn-On DelayTime			18		ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =10V, $V_{DS}$ =30V, $R_L$ =1 $\Omega$ ,		35		ns
t <sub>D(off)</sub>	Turn-Off DelayTime	$R_{GEN}$ =3 $\Omega$		44		ns
t <sub>f</sub>	Turn-Off Fall Time	7		23		ns
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =30A, dI/dt=100A/μs		53	64	ns
$Q_{rr}$	Body Diode Reverse Recovery Charge	I <sub>F</sub> =30A, dl/dt=100A/μs		98		nC

A: The value of R  $_{\rm \theta JA}$  is measured with the device in a still air environment with T  $_{\rm A}$  =25  $^{\circ}$  C.

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B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}$ =175 $^{\circ}$  C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C: Repetitive rating, pulse width limited by junction temperature  $T_{J(MAX)}$ =175° C.

D. The R  $_{\theta JA}$  is the sum of the thermal impedence from junction to case R  $_{\theta JC}$  and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300 μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedence which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(MAX)}$ =175° C.

G. The maximum current rating is limited by bond-wires.



#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

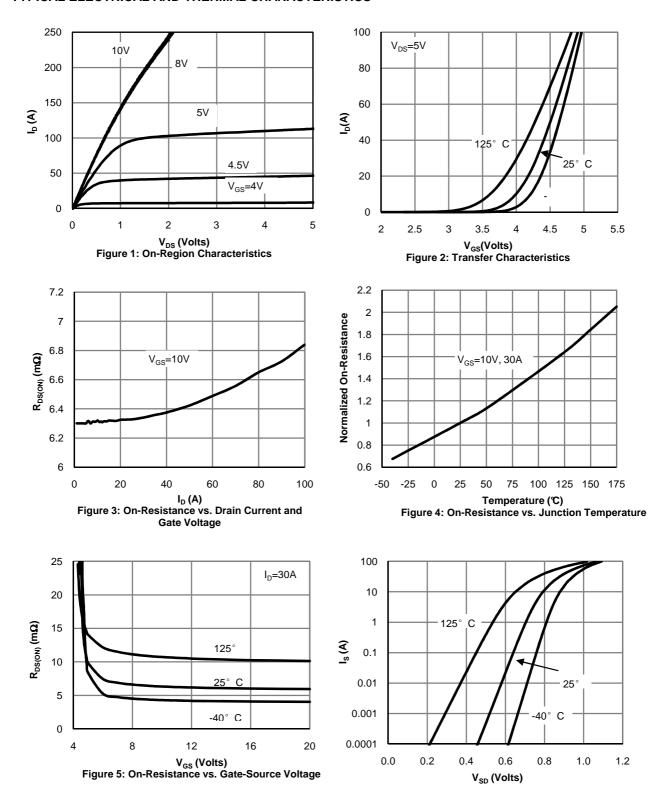


Figure 6: Body-Diode Characteristics



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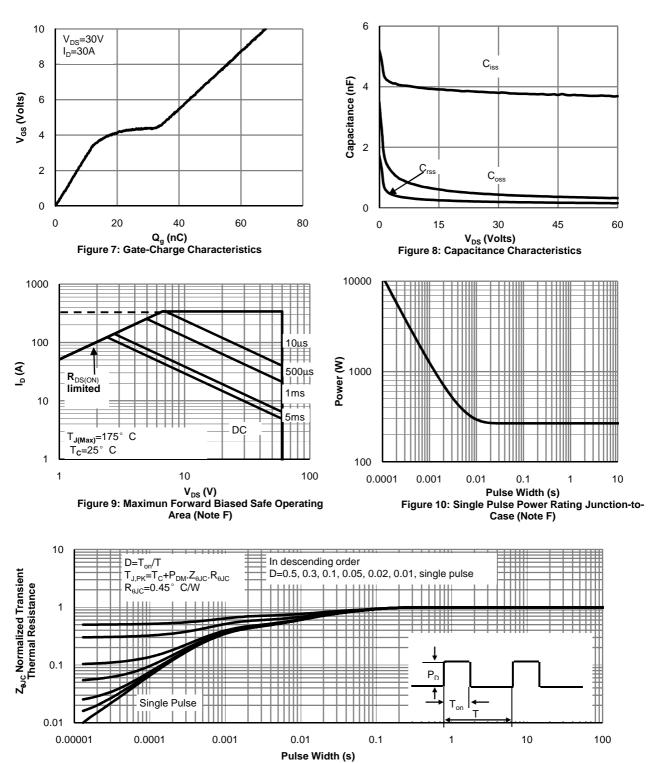
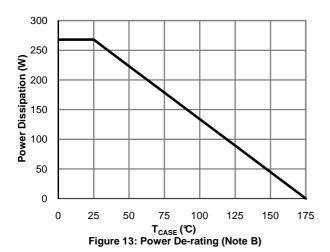
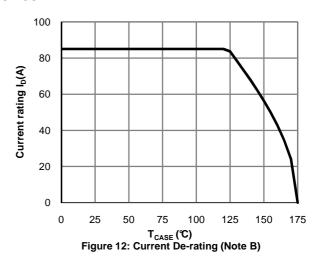


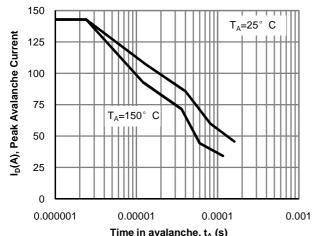
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)



### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



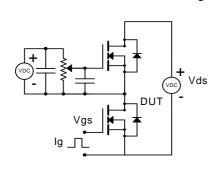


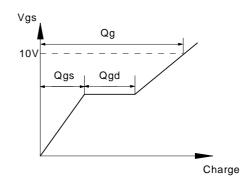


Time in avalanche,  $t_{\rm A}$  (s) Figure 10: Single Pulse Avalanche capability

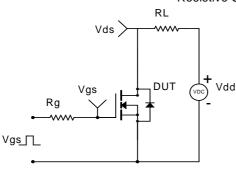


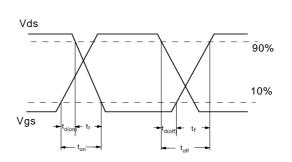
# Gate Charge Test Circuit & Waveform



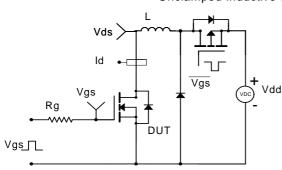


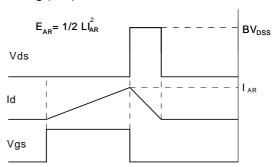
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





## Diode Recovery Test Circuit & Waveforms

